

Search Notes



Application No.

09/677,401

Examiner

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Applicant(s)

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Art Unit

3629

SEARCHED

Class	Subclass	Date	Examiner
705	1	12/20/04	DN
	14		
	17		
	35		
	38		
	39		
463	25		
235	380		
	381		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
I US	12/04	DN
PG Pub US Patent		
II FOREIGN		
1. EPO 2. JPO 3. Derwent		
III NPL		
Reviewing Previous case parent	12/04	DN